

# BE1M13VES

## Manufacturing of Electrical Components

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# Overview

- 1 Semiconductor Components
- 2 Light Dependent Resistor
- 3 Diodes
- 4 Transistors

# TOPIC

## 1 Semiconductor Components

## 2 Light Dependent Resistor

## 3 Diodes

## 4 Transistors

# Semiconductor Components

## Basic properties

- Nonlinear characteristics - used for rectifying, sensing, saturation etc.
- VA characteristics are quite dependent on ambient factors - temperature, light.
- Some components are able to amplify the input signal - transistors

# Doping

## **Intrinsic semiconductors (semiconductors without impurities):**

- The free charge is excited via temperature or light.
- Quite small conductivity dependent on ambient factors.

## **Extrinsic semiconductors (semiconductors with doped material):**

- Most of the free charge is excited at room temperature from impurities.
- Similar behavior as metal conductors (rising resistance with temperature).
- Two types of doped materials (dopants): **donors & acceptors**

# Doping

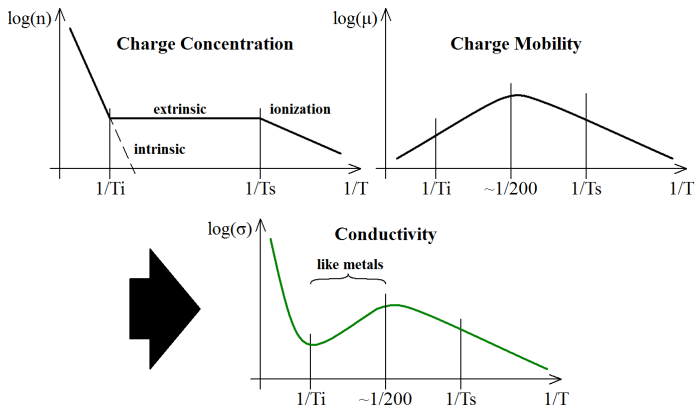
## Degenerate semiconductors

- High level of dopant.
- Almost the same behaviour as metal conductors.
- They are used to create contact layer between metal wire and semiconductor.

## Type of conduction

- Adding donors (5 valence electrons)  $\Rightarrow$  electrons conduction, type N (negative).
- Adding acceptors (3 valence electrons)  $\Rightarrow$  holes conduction, type P (positive).

# Temperature dependency



# Semiconductor Materials

**Element Materials:**

Si, Ge (old but still used in specific applications), ... (C, Sn  $\Rightarrow$  IV. element group)

**Compound materials:**

SiC (varistors and early LEDs), GaAs (LEDs), CdS (Photoresistors)

**Donors:**

(V. element group) P, As

**Acceptors:**

(III. element group) B, Al



# TOPIC

1 Semiconductor Components

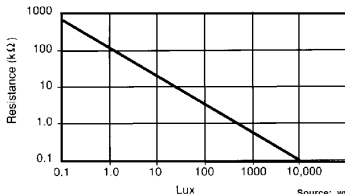
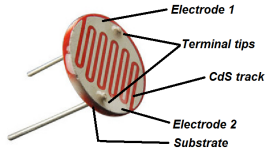
**2 Light Dependent Resistor**

3 Diodes

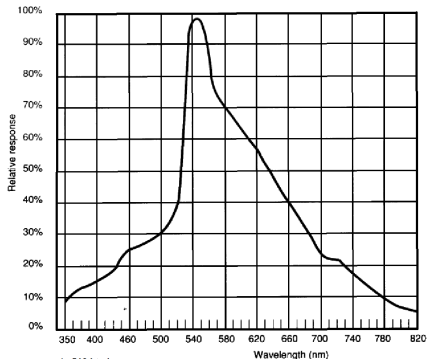
4 Transistors

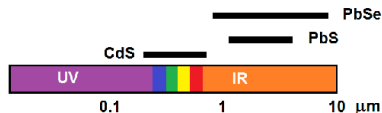
# LDR, Photoresistor - Basic properties

- The resistance decreases with illumination.
- The spectral light sensitivity depends on semiconductor material.



Source: [www.sunrom.com/p-510.html](http://www.sunrom.com/p-510.html)





- Materials: CdS, CdSe, PbS, PbSe, and others;
- **No PN junction** - one type of conductivity:
  - intrinsic - high resistance, sensitive to short wavelengths of light
  - extrinsic - smaller resistance, sensitive to longer wavelengths of light (IR)
- Dynamic response is exponential: **milliseconds**

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# Diode

The construction contain one junction between different types of semiconductor conductivity  $\Rightarrow$  PN junction.

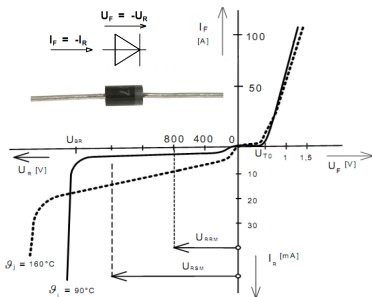
Shockley diode equation

$$I = I_0 \cdot \left( e^{\frac{U}{n \cdot U_T}} - 1 \right)$$

$I_0$  ... saturation current,

$U_T$  ...thermal voltage  
 $= kT/e,$

$n$  ...emission coefficient  
 $= \langle 1, 2 \rangle.$



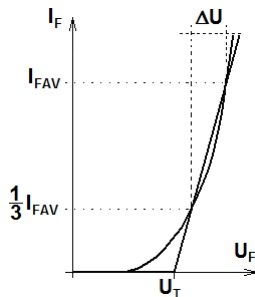
# Diode - Forward Orientation

$$U_F \approx U_T + I \cdot r_T$$

$U_T$  threshold voltage, for Si diode  
 $\approx 0.6 \text{ V}$ ,

$r_T$  dynamic resistance.

$$r_T \approx \frac{\Delta U}{\Delta I} = \frac{3 \cdot \Delta U}{2 \cdot \Delta I_{FAV}}$$



Very small forward voltage and high reverse (breakdown) voltage are good properties for rectifying.

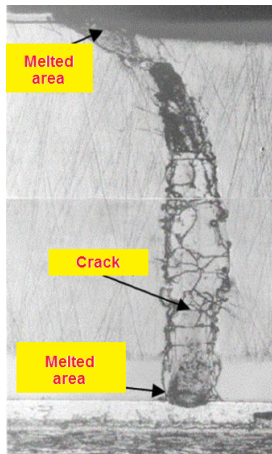
# Diode - Reverse Orientation

Breakdowns:

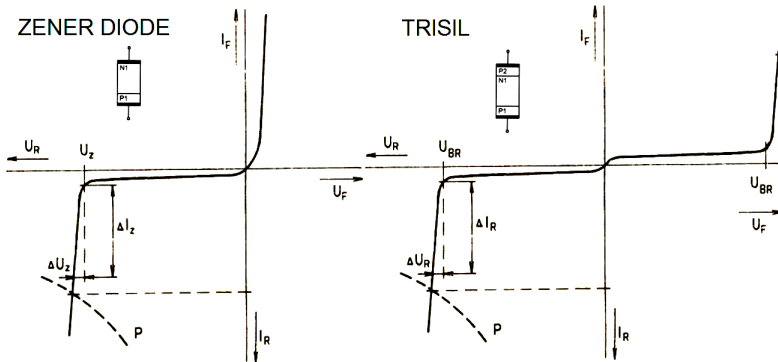
- 1 **electrical**... nondestructive, component handles the power loss (Zener diode and trisils).
- 2 **thermal**... destructive, the power loss melts the semiconductor layer.

Breakdown Mechanisms:

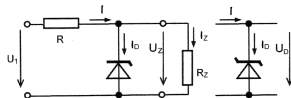
- 1 Avalanche -  $U_{BR}$  increases with temperature, in case  $U_{BR} < 6\text{ V}$
- 2 Quantum tunnelling -  $U_{BR}$  decreases with temperature



# Zener Diode and Trisil



They are used as voltage reference or protection (common voltages  $\langle 2\text{ V}, 200\text{ V} \rangle$ ).





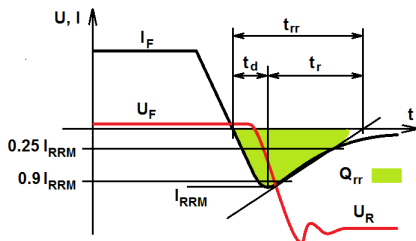
# Dynamic Behavior

Reverse Recovery:

$t_{rr}$  reverse  
recovery time

$t_d$  time of delay

$t_f$  time of fall



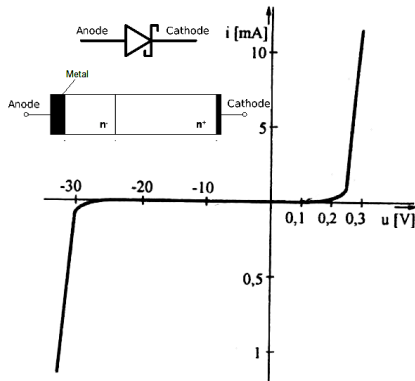
There is stored charge in the diode. The charge must be removed during the change of voltage polarity to recover reverse state of the diode.

After approximation by a triangle:

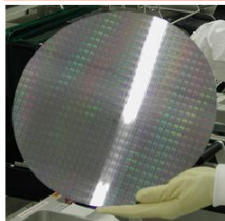
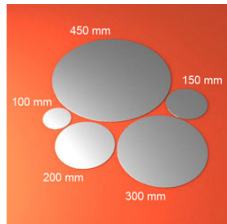
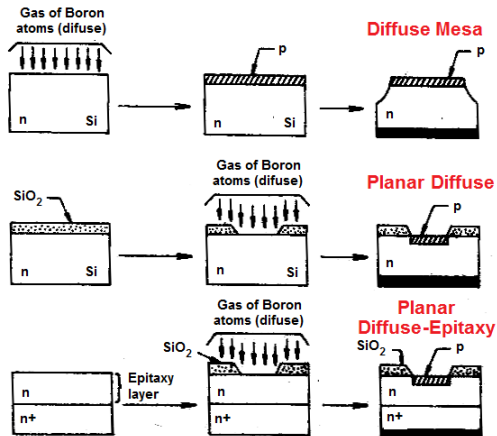
$$Q_{rr} = \frac{1}{2} \cdot I_{RRM} \cdot t_{rr}$$

# Schottky diode

- Junction between semiconductor and metal.
- Smaller threshold voltage (0.3 V).
- Smaller recovery charge  $Q_{rr}$  (fast).
- Smaller breakdown voltages (common max 50 V, rare up to 200 V)



# Diodes - Technology



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# Bipolar Transistors - Basic Properties

Component with two PN junction and three electrodes:

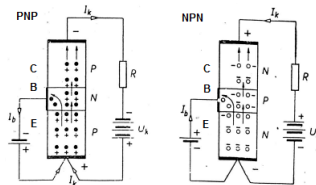
**BASE** ... affect, control the current flow between COLLECTOR and EMITTER

**COLECTOR** ... collects the electrons flowing through BASE.

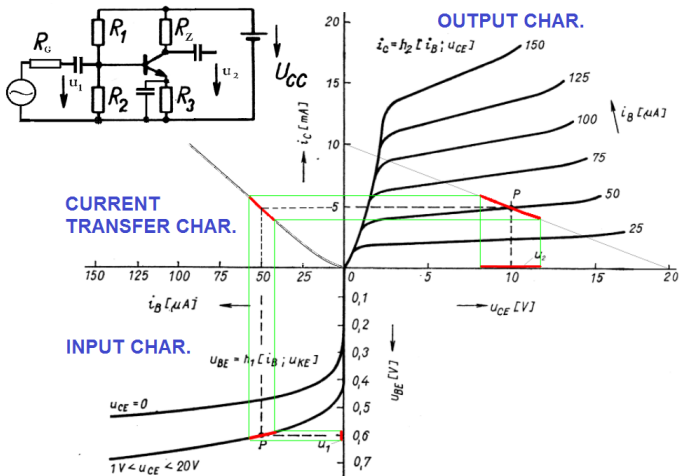
**EMITTER** ... emits the electrons to the base.

Arrangements: NPN, PNP

Applications: Amplifiers, switches

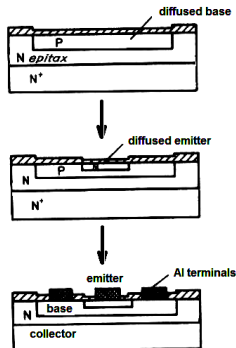


# Transistors - Characteristics



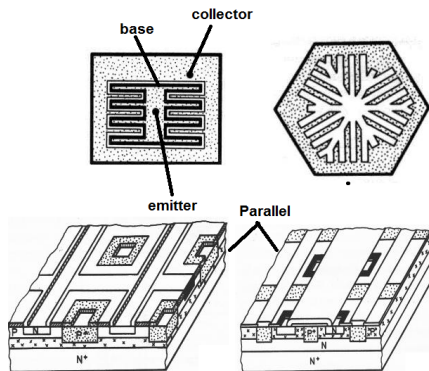
# Technology

Planar diffuse-epitaxy: epitaxy layer has thickness  $10\text{ }\mu\text{m}$  and it is created on degenerated semiconductor (similar to diodes technology).



- 1 Creating the epitaxy N layer,
- 2 diffuse of boron,
- 3 creating of  $\text{SiO}_2$  layer,
- 4 mask etching,
- 5 diffuse phosphor,
- 6 another  $\text{SiO}_2$  layer and etching,
- 7 creating terminals.

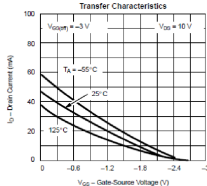
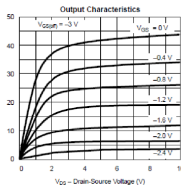
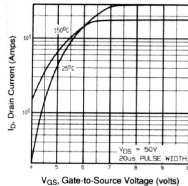
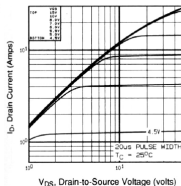
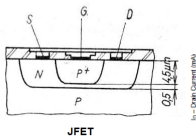
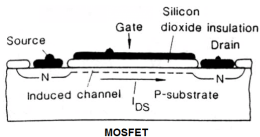
# Structures



The large emitter area is needed to get high current capability. The current density is the highest at the edge of emitter layer. Therefore the structures with long edge are preferred.

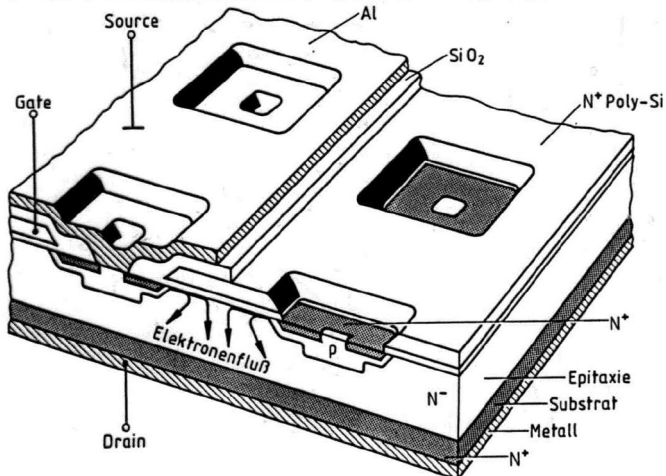


# Unipolar types



The flow of the current is controlled via electric field  $\Rightarrow$  gate with low consumption.

# SIPMOS Technology



# HEXFET Technology

